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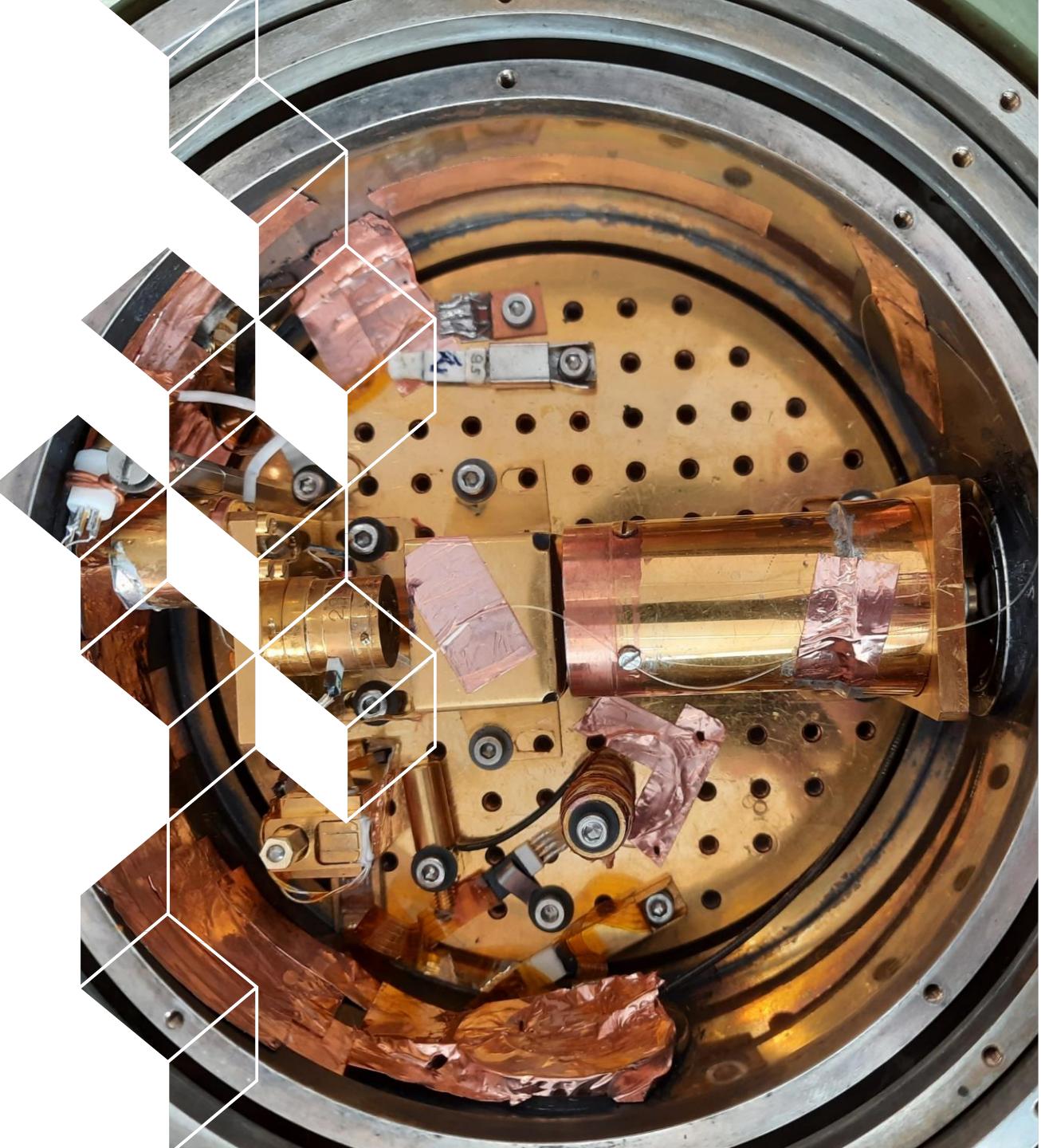
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Radionuclide-free efficiency calibration of an HPGe detector using monochromatic photon beams measured with a cryogenic radiometer

Víctor H. Elvira, Yves. Ménesguen, Marie-Christine Lépy





Motivation

Accurate measurement of fundamental parameters, such as X-ray emission intensities, require **well-calibrated spectrometers in terms of efficiency**

In the **conventional approach**, efficiency calibration is carried out by using radionuclides standards, calibrated in activity, and **previously known photon emission probabilities**

$$\varepsilon(E) = \frac{N(E)}{A I(E) t} \prod_i C_i$$

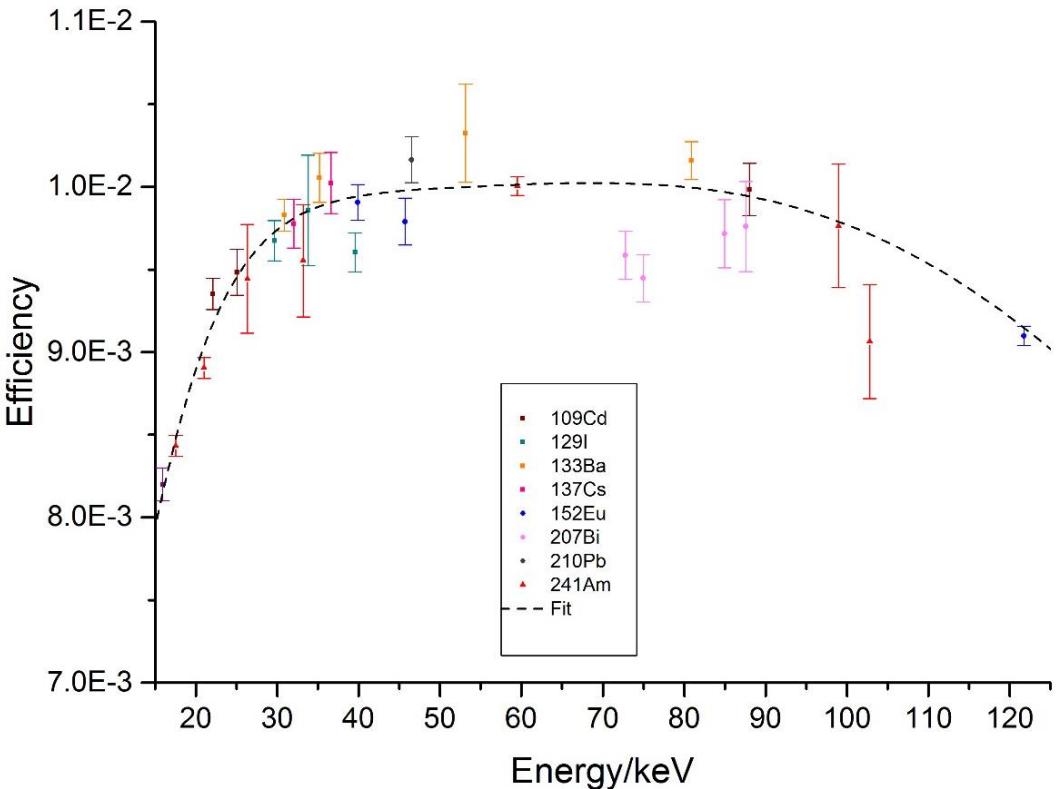
N(E): Net peak area t: counting time (live time)
A: source activity I(E): photon emission intensity *C_i: correction factors*

- Photon emission intensities measurements and efficiency calibration strongly linked
Intrinsic limitation: we rely on the same probabilities we intend to measure
- Few radionuclides for calibration
- Correlation between emission intensities

$$I_{XK} = P_\gamma \frac{\alpha_K}{1 + \alpha_T} \omega_K \quad I_{XK} = P_\varepsilon P_K \omega_K$$

Motivation

- Inconsistency in nuclear data
- E.g. Systematic difference of experimental results using ^{133}Ba (53.2 keV) and ^{241}Am (59.5 keV)





Motivation

SOLUTION

Using well-measured photon fluxes whose calibration is
independent of any previously measured **fundamental parameter**

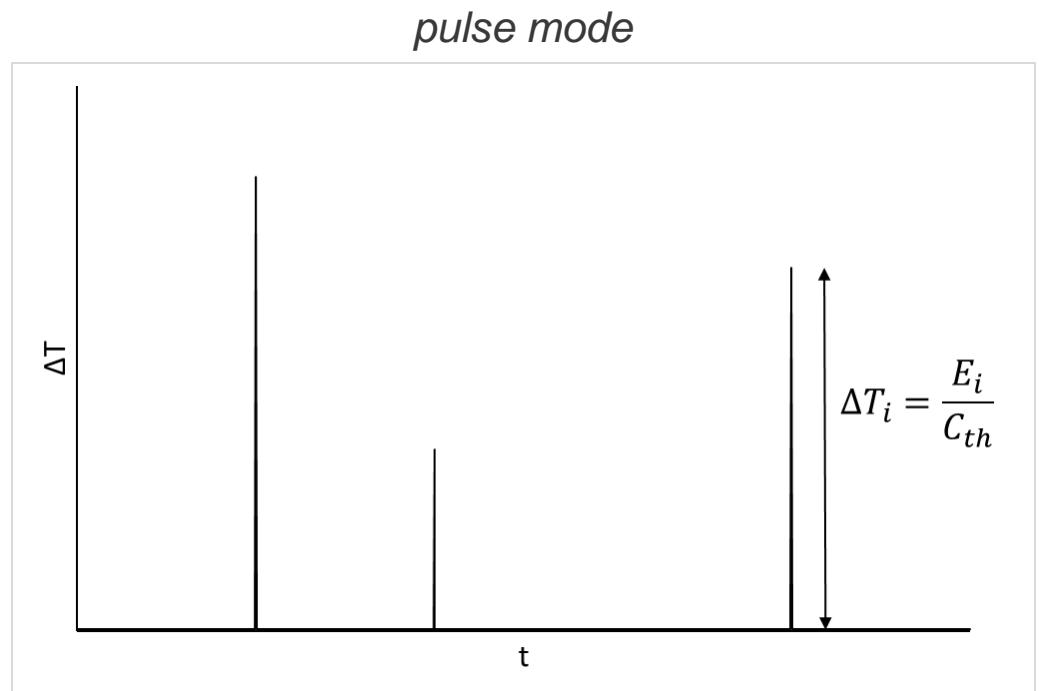
This approach requires
ABSOLUTE MEASUREMENT OF PHOTON FLUXES



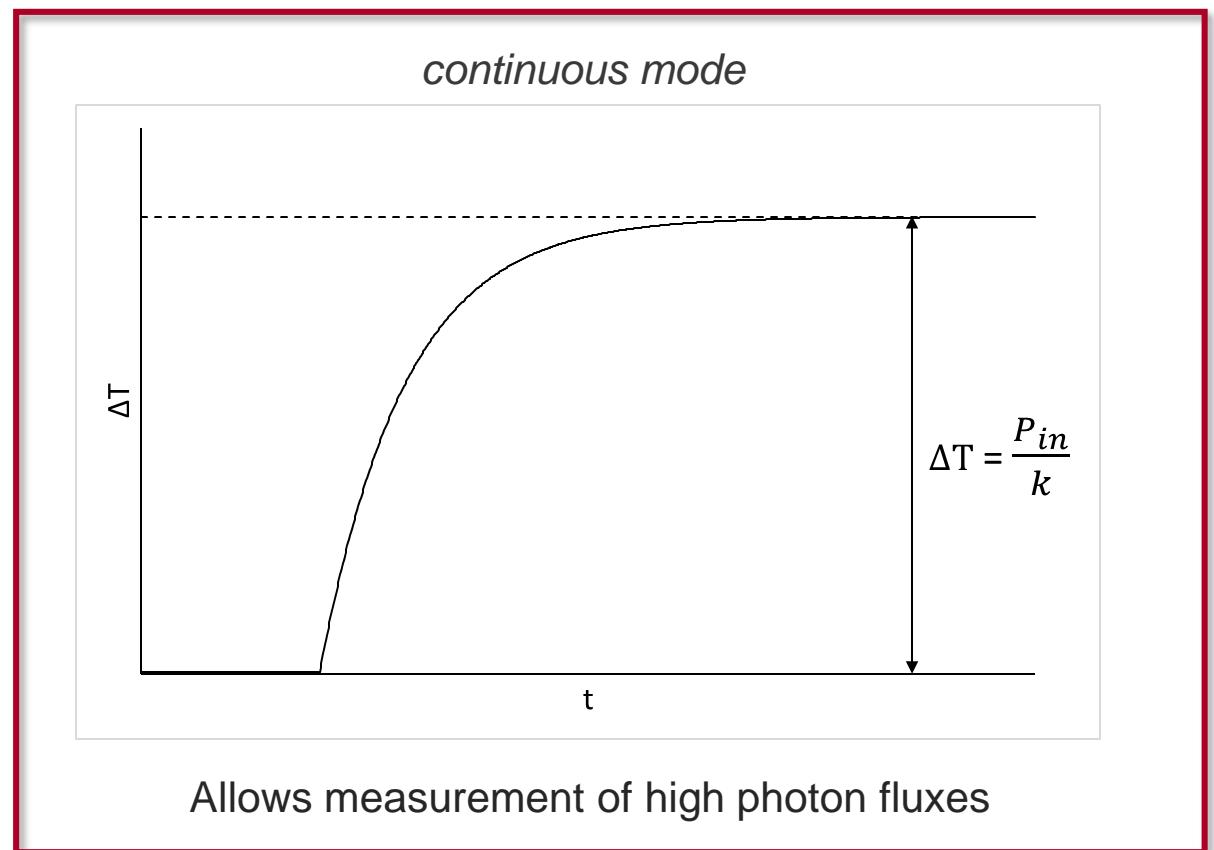
CRYOGENIC DETECTORS

Cryogenic detectors

When radiation interacts with an absorber, it provokes a **temperature rise**, ΔT , which is proportional to the energy of the incident radiation



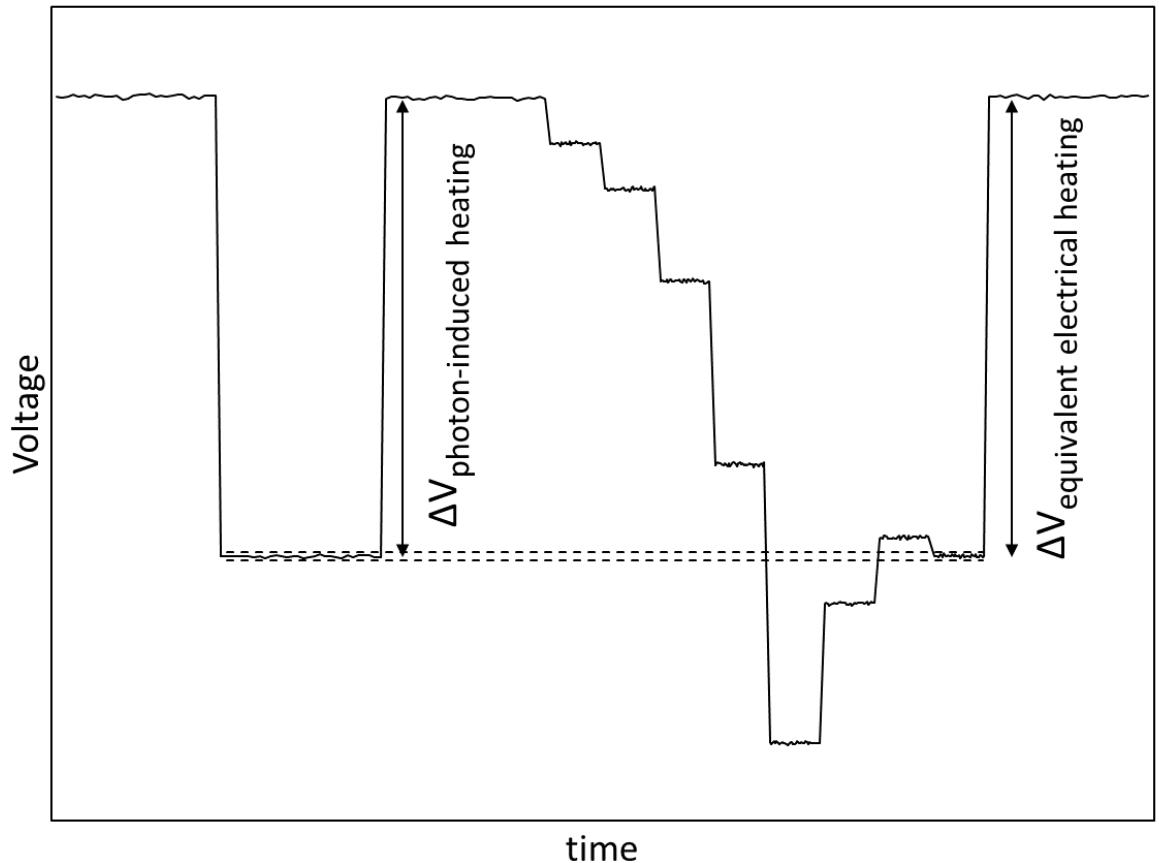
Allows spectroscopy



Allows measurement of high photon fluxes

Cryogenic detectors

PRINCIPLE OF ELECTRICAL SUBSTITUTION

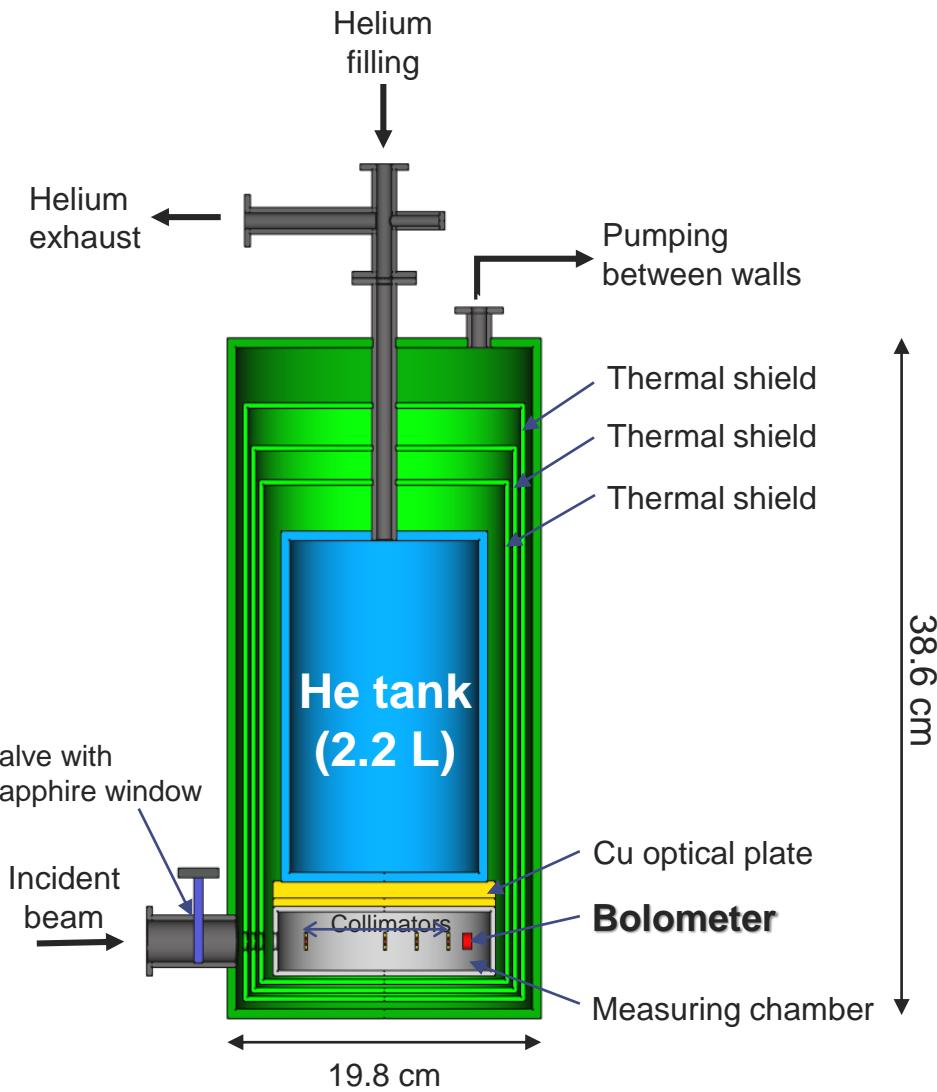


The amount of energy deposited by the radiation can be known by finding the **electrical power** that needs to be transferred to the absorber in order to obtain **the same temperature rise**

$$\eta P_{\text{rad}} = IR^2$$

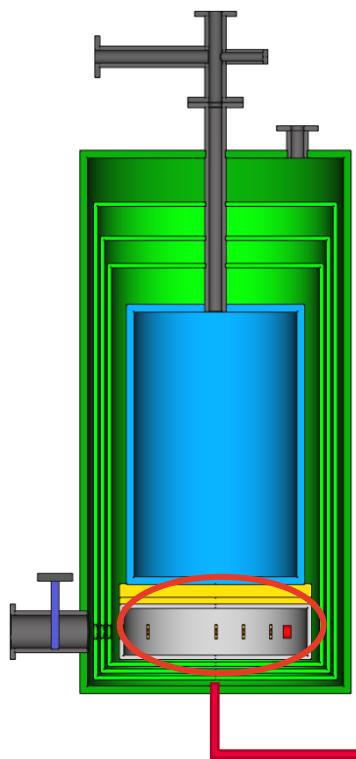
A **thermistor** linked to the absorber is polarized with a constant current so that the **decrease in resistance** provoked by the **temperature rise** causes a **decrease in tension**

BOLUX - BOlometer for Use in the range of X-rays

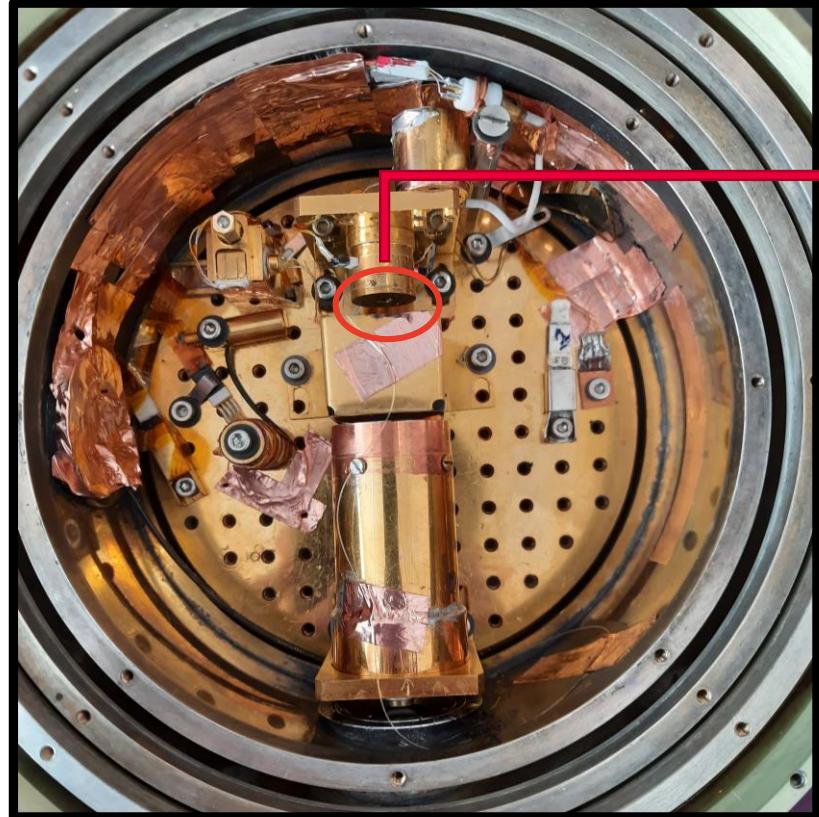


BOLUX - BOlometer for Use in the range of X-rays

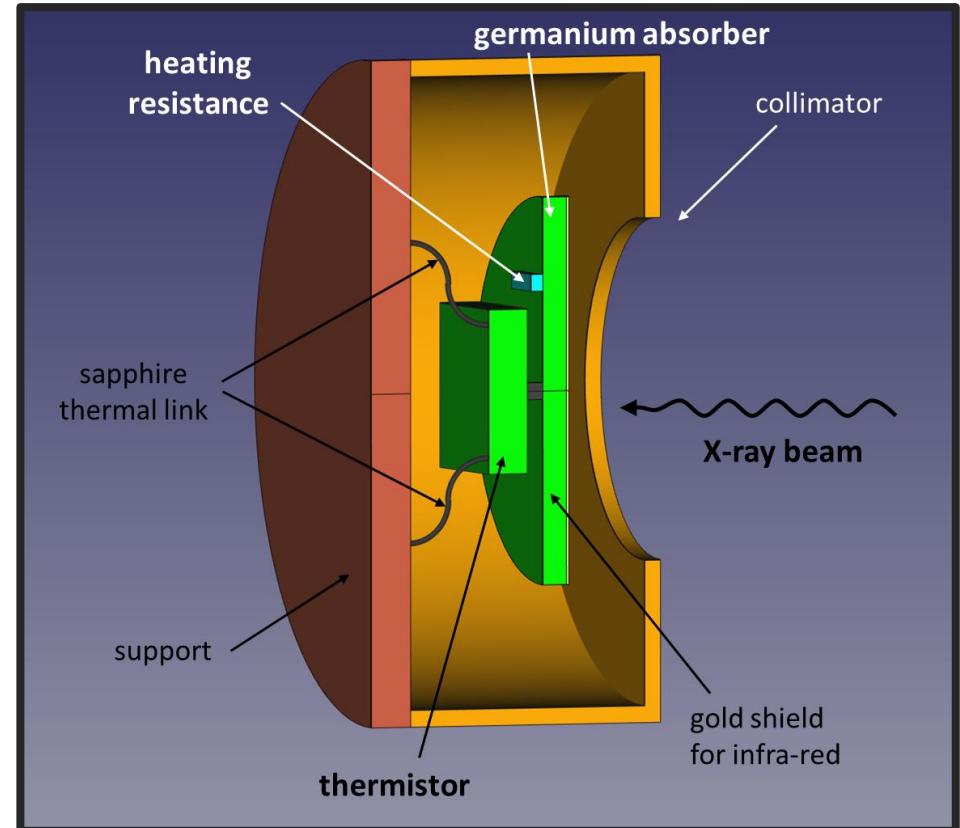
Cryostat



Measuring chamber



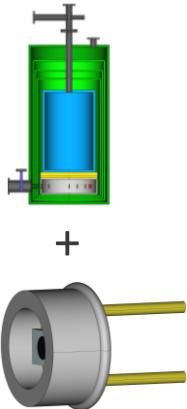
Bolometer



Measurements

1st step, with a high photon flux ($\sim 10^9$ ph/s)

BOLUX
Measurement of the beam power



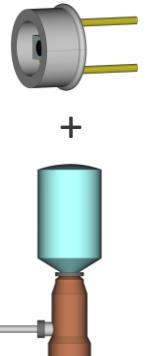
Photodiode
Measurement of the current induced

Efficiency of the photodiode
 Eff

$$\frac{\text{Current (A)}}{\text{Beam Power (W)}}$$

2nd step, with a much lower photon flux ($\sim 10^3$ ph/s)

Photodiode
Measurement of the number of emitted photons per second



$$\frac{\text{Current}}{Eff \cdot E_{\text{photon}}}$$

Semiconductor detector
Measurement of count rate

Efficiency of the semiconductor detector

$$\frac{\text{Count rate}}{\text{Emitted photons/second}}$$

The efficiency of both BOLUX and the photodiode depend on the **photon's energy**

but neither of them are able to discriminate photons by energy



Monochromatic radiation



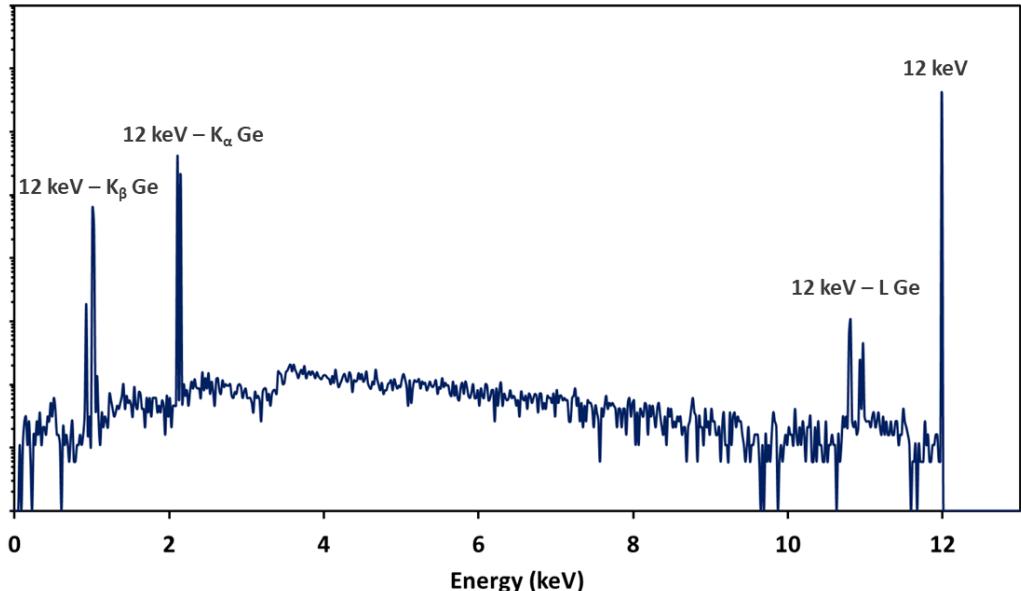
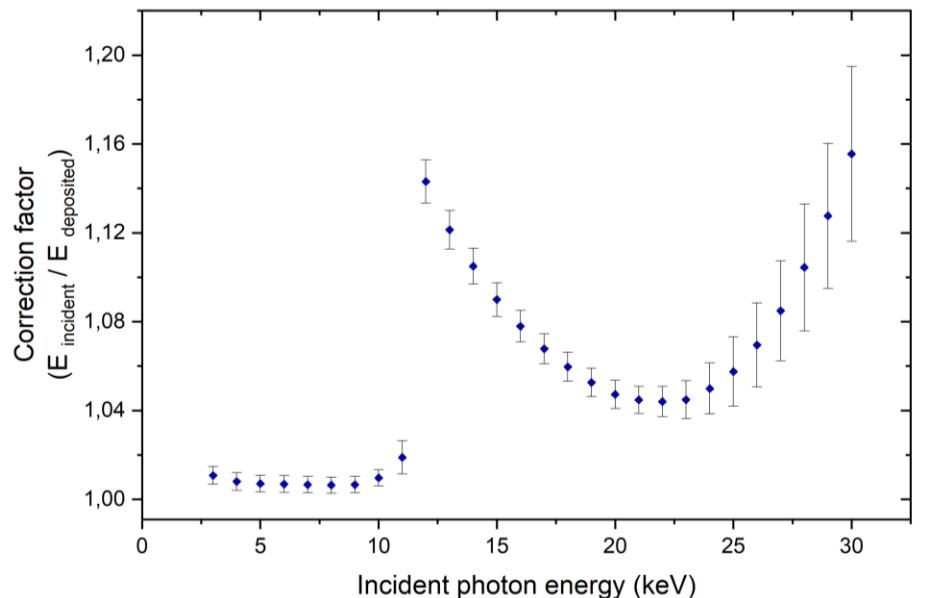
Measurements

Preliminary: calculation of the correction factor for BOLUX

Average energy deposited in the absorber per incident photon

Below 100 % due to

- Photons that do not interact with the absorber (**transmission**)
- Photons that do interact but do not deposit all of their energy
 - Characteristic X-ray escape
 - Scattering



Monte Carlo simulations

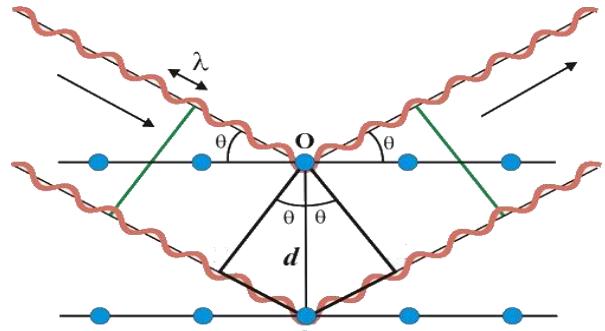
PENELOPE

PENetration and **EN**ergy **LO**ss of **P**ositrons and **E**lectrons ^t

^t F. Salvat, OECD/NEA Data Bank (2015)

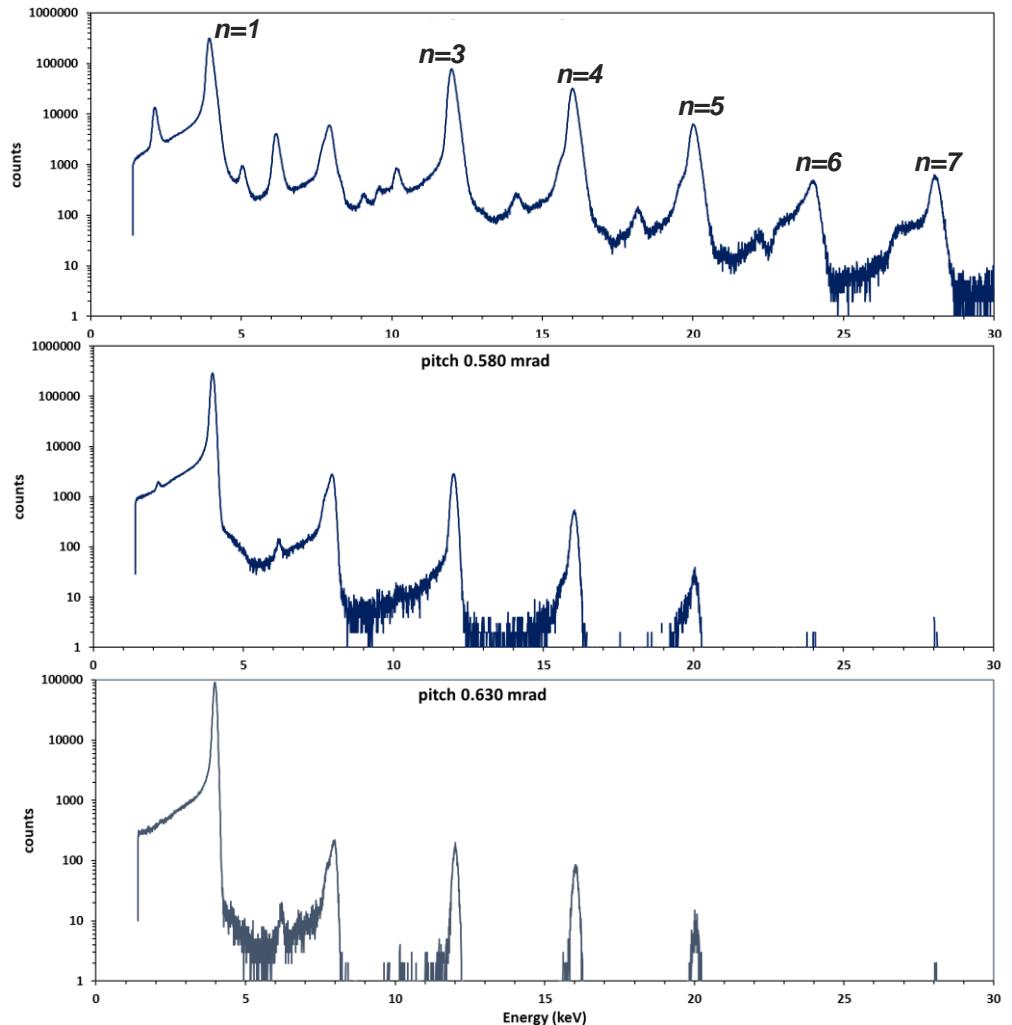
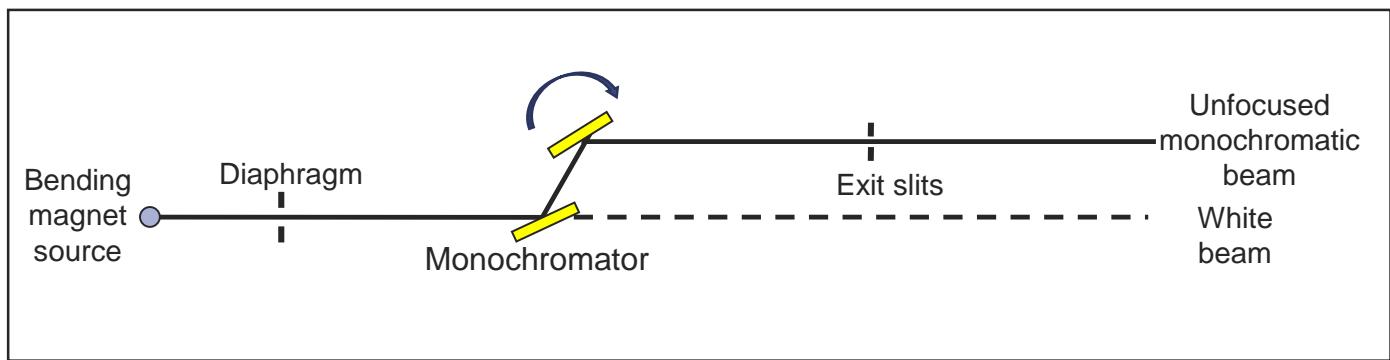
Measurements

Preliminary: optimization of the beam – study of harmonics



$$2d \sin \theta_B = n\lambda$$

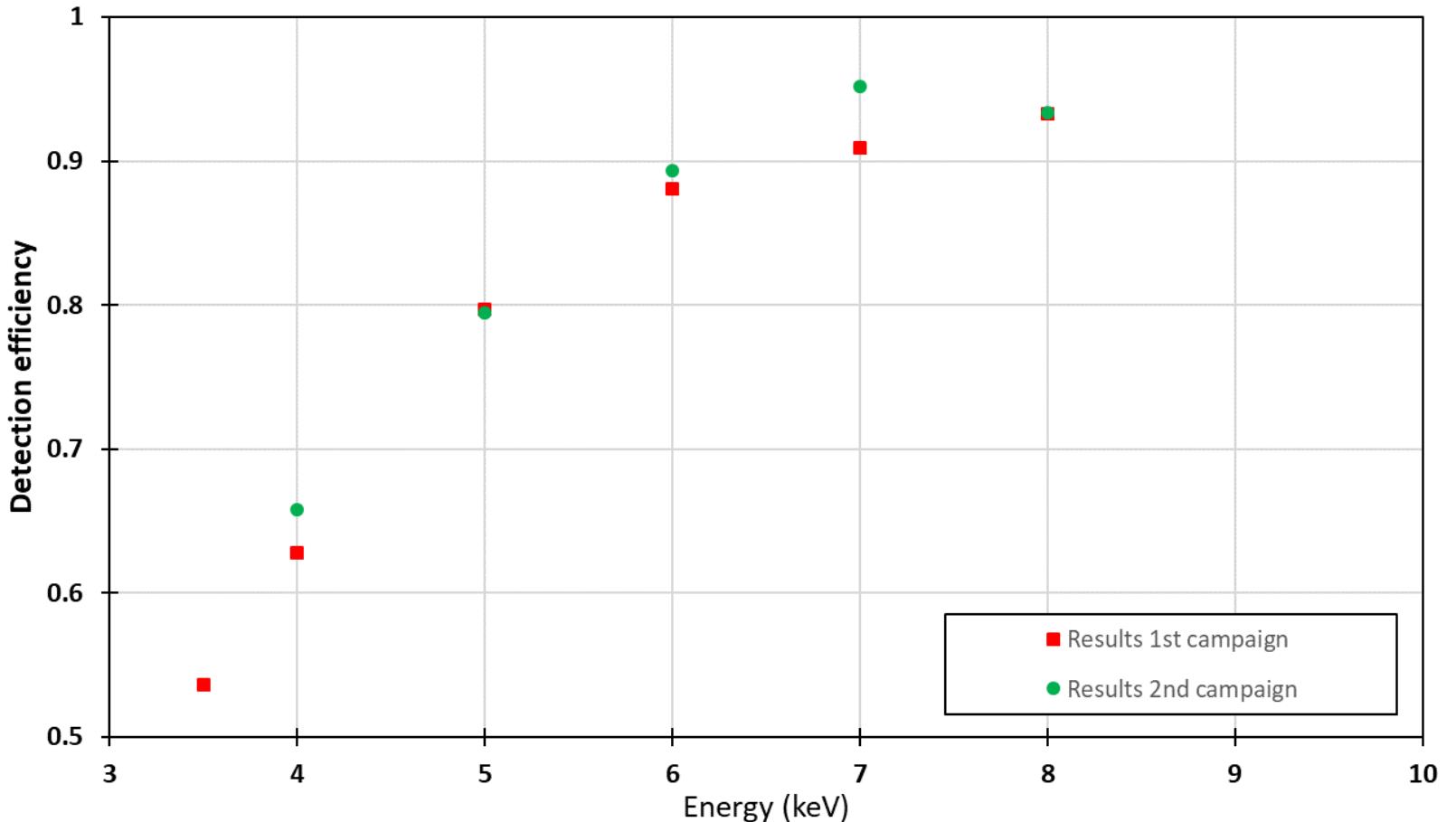
Detuning (pitch) of the second crystal to suppress higher-order harmonics



Measurements

Calibration of a HPGe

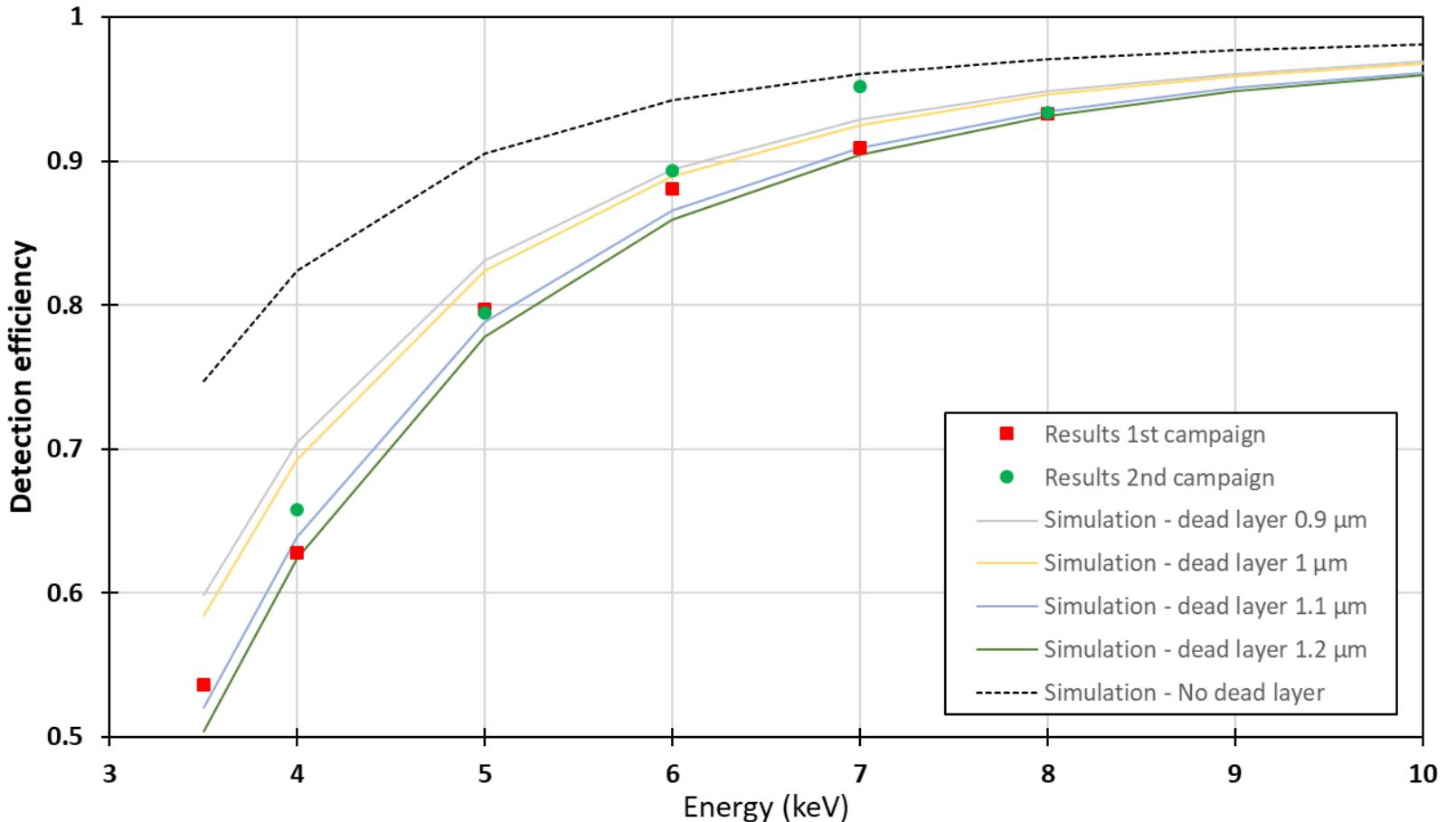
Results for 3.5 keV – 8 keV



Measurements

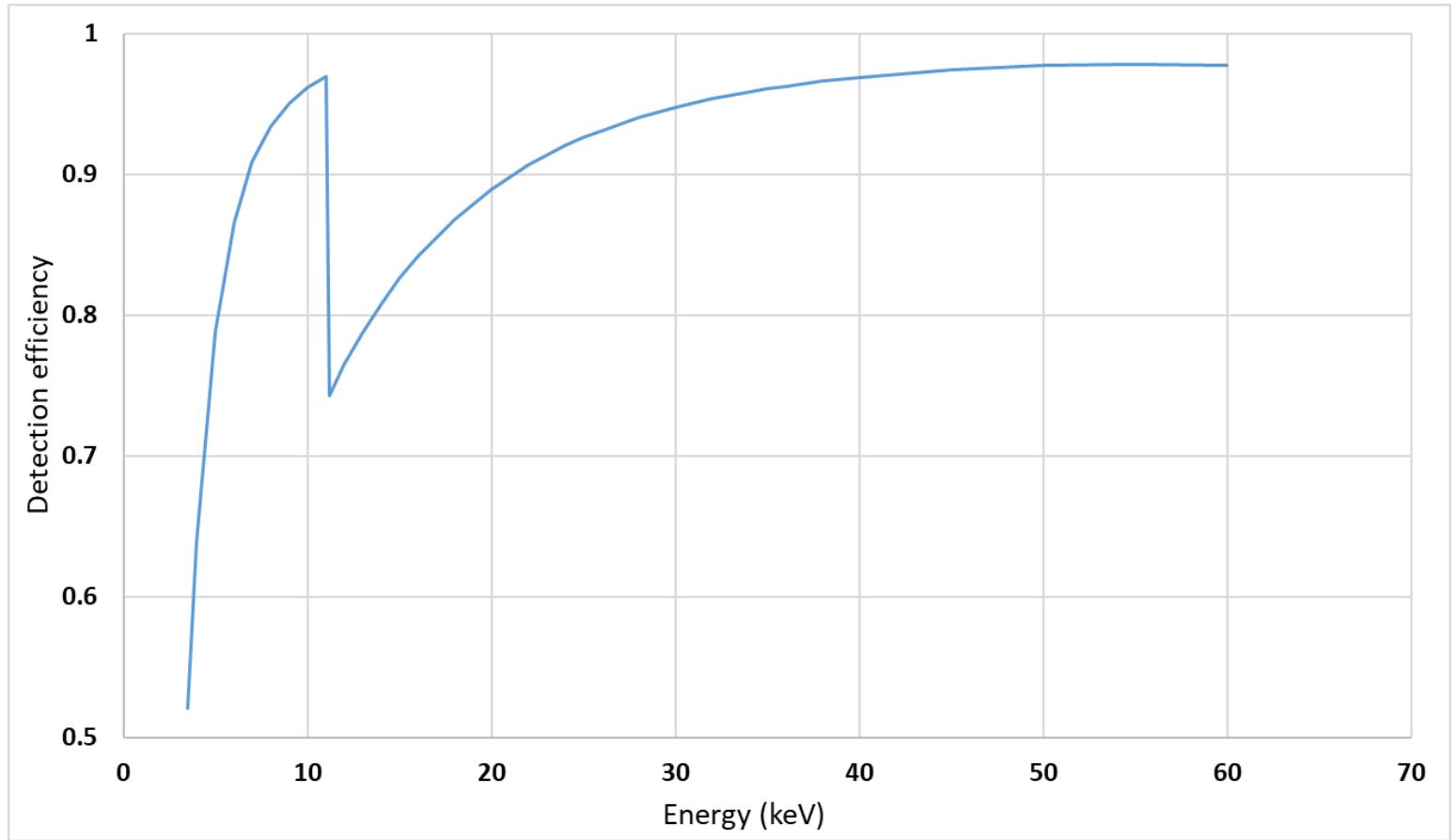
Calibration of a HPGe

Optimization of the dead layer



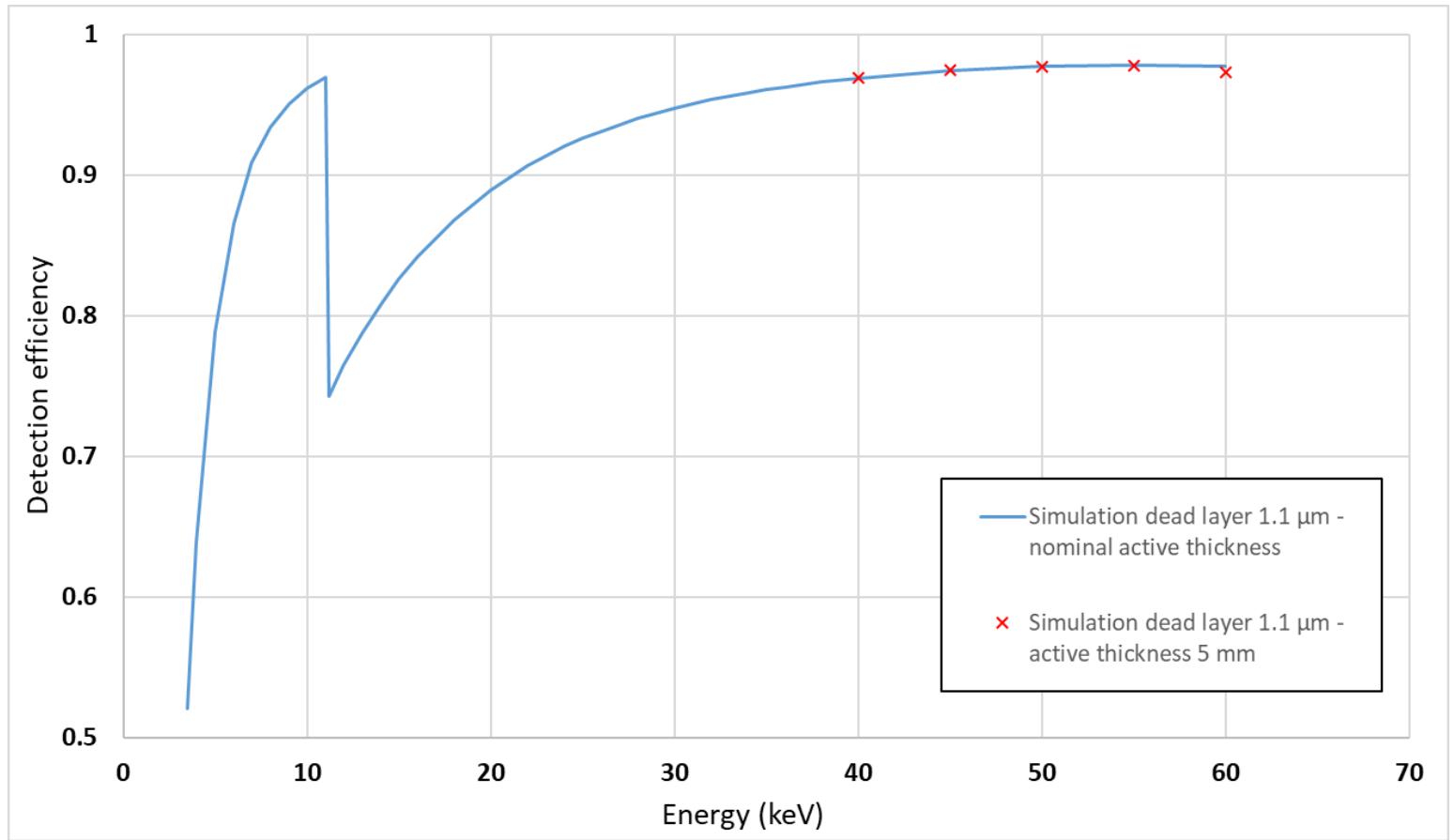
Exploiting experimental results

Extension of the energy interval
via Monte Carlo simulations



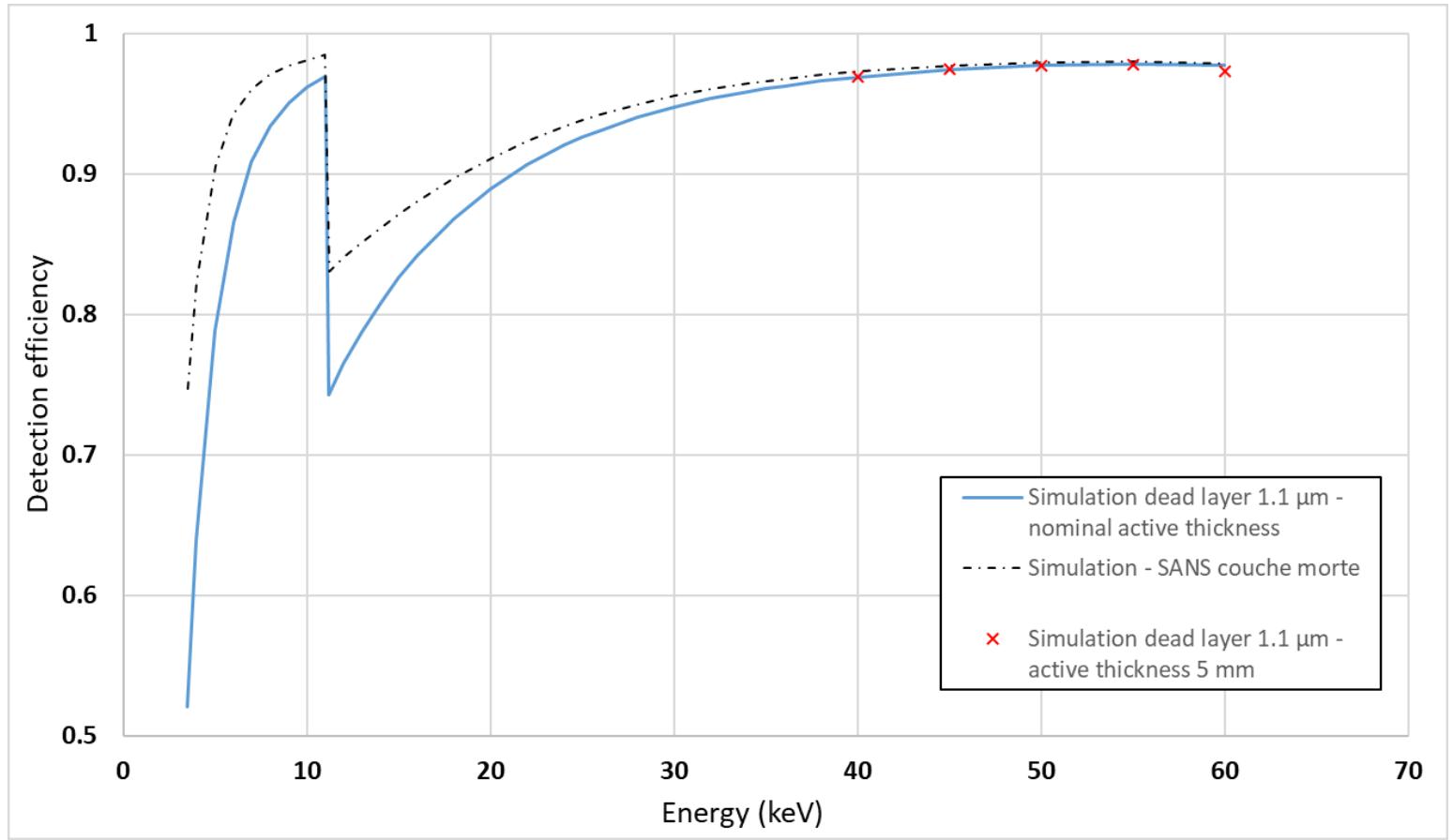
Exploiting experimental results

Extension of the energy interval
via Monte Carlo simulations



Exploiting experimental results

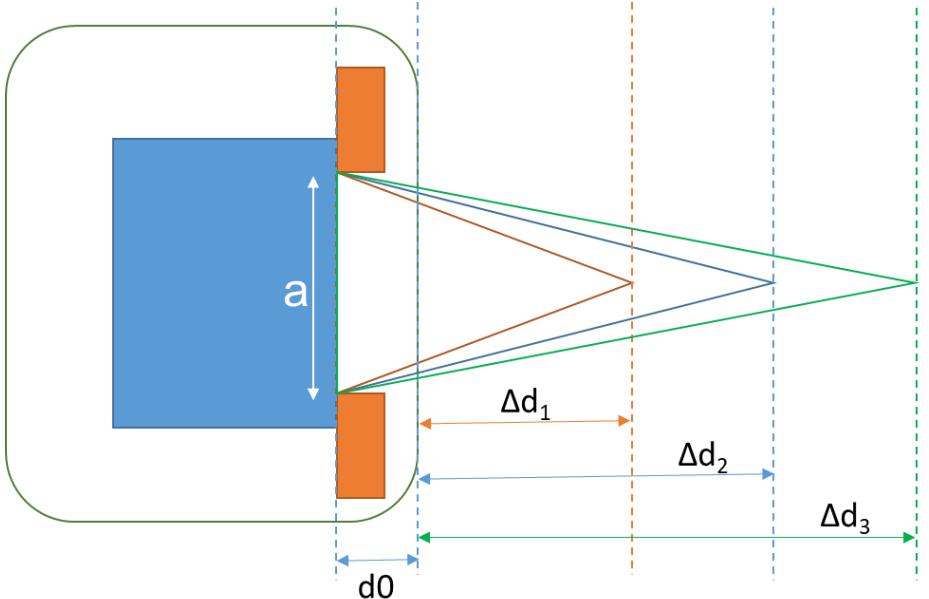
Extension of the energy interval
via Monte Carlo simulations



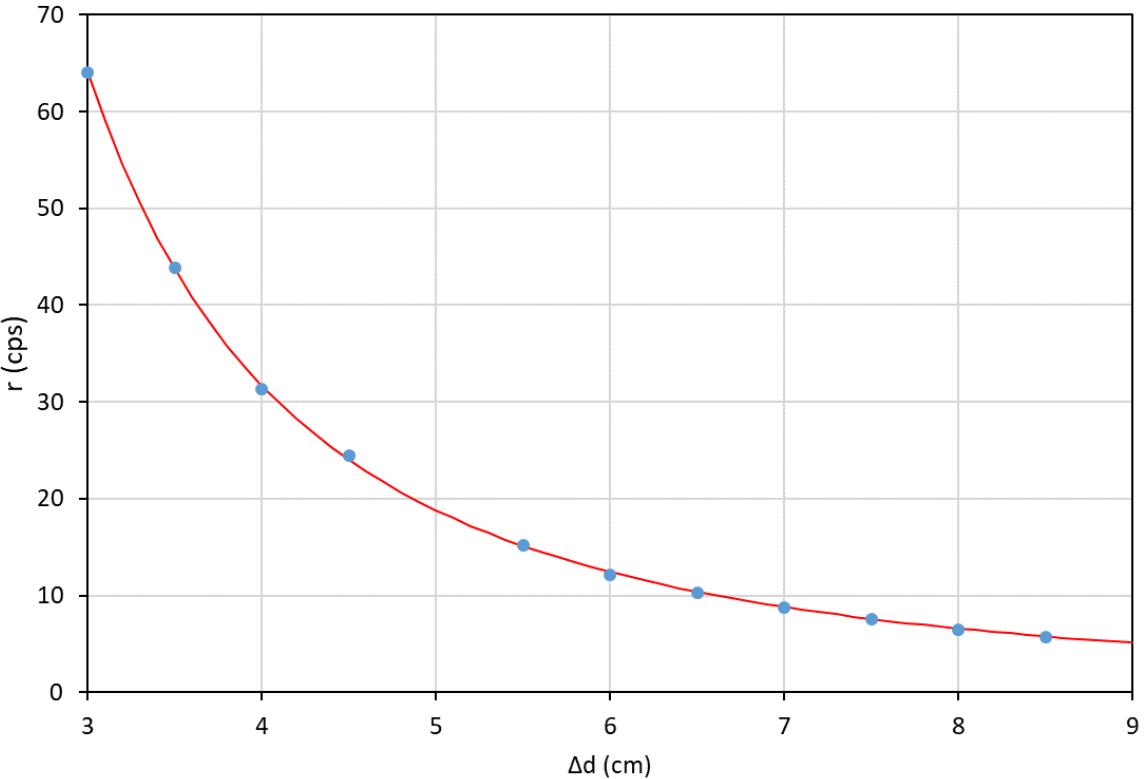
Exploiting experimental results

Determination of geometric efficiency

$$\varepsilon(E) = \varepsilon_{intr}(E) \cdot \varepsilon_{geom} = \varepsilon_{intr}(E) \cdot \Omega/4\pi$$



$$r = r_{4\pi} 0.5 \left(1 - \frac{(d_0 + \Delta d)}{\sqrt{(d_0 + \Delta d)^2 + a^2}} \right)$$

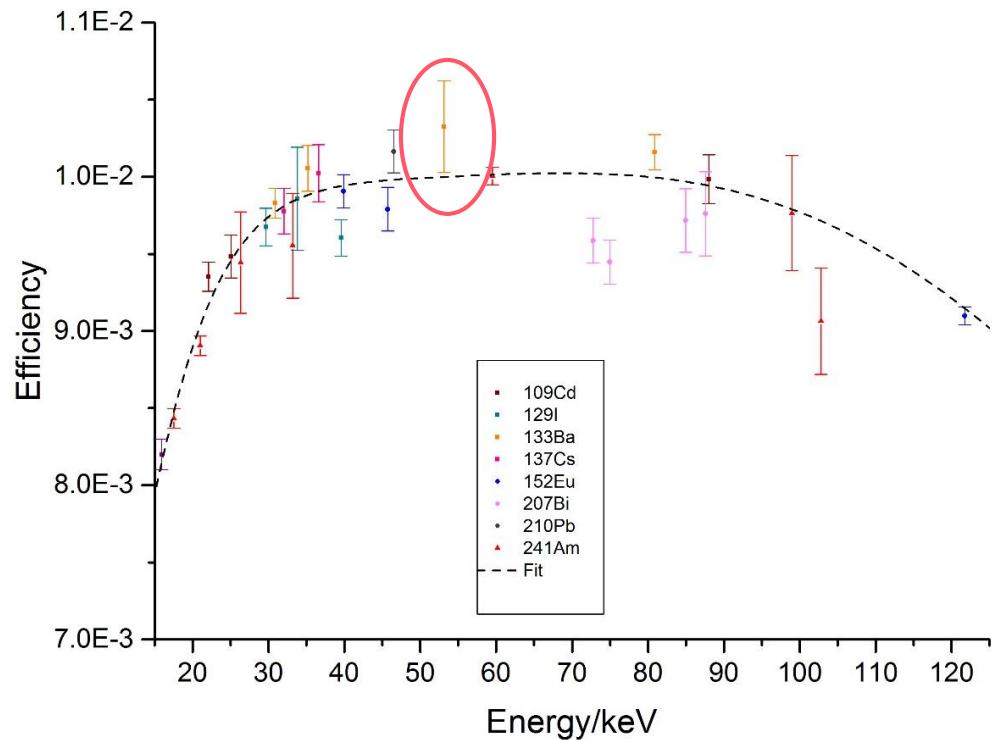


Measurement of ^{133}Ba k_α count rate of the same source at variable distance

Application to the determination of photon emission intensities

Preliminary measurements of I_{γ} 53 keV of ^{133}Ba

| I_{γ} (53 keV) ^{133}Ba | |
|---|-------------|
| DDEP 2004 | 2.14 (3) |
| DDEP 2016 | 2.14 (6) |
| This work | 2.25 |
| Lépy et al. (2018) * | 2.229 (23) |



* M.-C. Lépy, L. Brondeau, Y. Ménesguen, S. Pierre, J. Riffaud
Appl. Radiat. Isot., 134 (2018), pp. 131-136

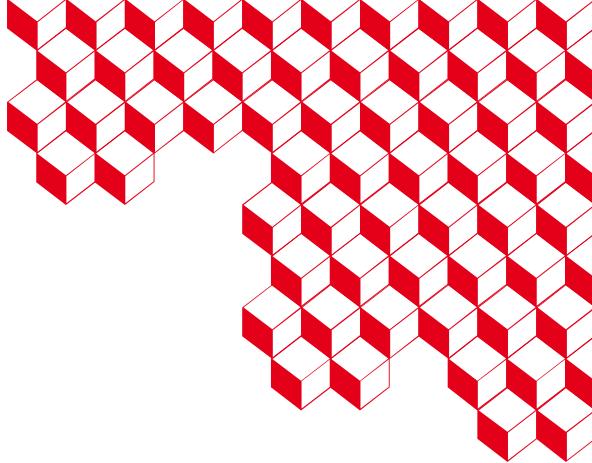
Conclusions

Successfully accomplished

- Set-up and restart of cryogenic detector *BOLUX*
- Absolute measurement of synchrotron photon flux intensities
- Determination of the intrinsic efficiency of a HPGe in the energy range where the thickness of the dead layer is critical
- Extrapolation of the efficiency curve via Monte Carlo simulations to the whole energy range where the active thickness is not critical (3 - 55 keV)
- Determination of the geometric efficiency through the measurement of the same source at variable distances
- Preliminary measurement of ^{133}Ba γ -emission intensity at 53 keV. Promising results

In progress – future work

- Geometrical characterization of the HPGe for the accurate determination of the geometric efficiency
- Refinement of measurement of ^{133}Ba γ -emission intensity at 53 keV and extension to other photon emission intensities of radionuclides of interest: $^{93\text{m}}\text{Nb}$, ^{152}Eu , $^{103\text{m}}\text{Rh}$...



Thank you for your attention!

Mulțumesc foarte mult!

Merci beaucoup !

¡Muchas gracias!

*We gratefully acknowledge
Synchrotron SOLEIL and the
team of Métrologie Beamline!*

Víctor H. Elvira, Yves Ménesguen, Marie-Christine Lépy

victor.hernandez-elvira@cea.fr



Testing solid angle fit

According to the [activity of the source](#), and taking emission [intensities from bibliography](#) and correcting for the intrinsic efficiency of the detector, the expected emission rate of ka in 4π would be [9908.6 cps](#)

We measured ka count rate at a fixed position and calculated the emission rate in 4π relying on the solid angle obtained from the fit with [a = 4 mm](#) and correcting for intrinsic efficiency. This leads to [9309 cps](#) in 4π

We try several fits at different a fixed. The one that predicts the expected value the best is $a = 3.88 \text{ mm}$

| Model | GOUDURIX (User) |
|-----------------|-------------------------------|
| Equation | $A*(1-1/sqrt(1+(4/(B+x))^2))$ |
| Plot | ka TOT corr att et decay |
| A | $4422,30761 \pm 53,39771$ |
| B | $-6,76712 \pm 0,1653$ |
| Reduced Chi-Sqr | 0,05315 |
| R-Square (COD) | 0,99986 |
| Adj. R-Square | 0,99985 |

Nominal radius

| Model | GOUDURIX (User) |
|-----------------|-------------------------------|
| Equation | $A*(1-1/sqrt(1+(R/(B+x))^2))$ |
| Plot | ka TOT corr att et decay |
| A | $4777,66041 \pm 57,774$ |
| B | $-6,73852 \pm 0,1655$ |
| R | $3,85 \pm 0$ |
| Reduced Chi-Sqr | 0,0534 |
| R-Square (COD) | 0,99986 |
| Adj. R-Square | 0,99985 |

| Model | GOUDURIX (User) |
|-----------------|-------------------------------|
| Equation | $A*(1-1/sqrt(1+(R/(B+x))^2))$ |
| Plot | ka TOT corr att et decay |
| A | $4536,27086 \pm 54,80089$ |
| B | $-6,75746 \pm 0,16536$ |
| R | $3,95 \pm 0$ |
| Reduced Chi-Sqr | 0,05323 |
| R-Square (COD) | 0,99986 |
| Adj. R-Square | 0,99985 |

| Model | GOUDURIX (User) |
|-----------------|-------------------------------|
| Equation | $A*(1-1/sqrt(1+(R/(B+x))^2))$ |
| Plot | ka TOT corr att et decay |
| A | $4654,62532 \pm 56,32543$ |
| B | $13,25201 \pm 0,16593$ |
| R | $3,9 \pm 0$ |
| Reduced Chi-Sqr | 0,05332 |
| R-Square (COD) | 0,99986 |
| Adj. R-Square | 0,99985 |

| a | $r_{4\pi}$ | $r_{4\pi} / \epsilon_{\text{intr}}$ |
|-------------|-------------|-------------------------------------|
| 4 | 8844 | 9309 |
| 3.95 | 9072 | 9549 |
| 3.9 | 9308 | 9798 |
| 3.88 | 9406 | 9901 |
| 3.87 | 9456 | 9954 |
| 3.85 | 9556 | 10059 |
| 3.80 | 9810 | 10326 |

Accurate value of a , to be confirmed by characterization by X-ray imaging

Measurements

Calibration of a Silicon-Drift Detector

